


<b>Search Notes</b>  	<b>Application/Control No.</b>  10730657	<b>Applicant(s)/Patent Under Reexamination</b>  MEEK ET AL.
	<b>Examiner</b>  Asfand M Sheikh	<b>Art Unit</b>  3627

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
EAST Search (see attached)	12/8/2008	/ ams /

INTERFERENCE SEARCH			
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